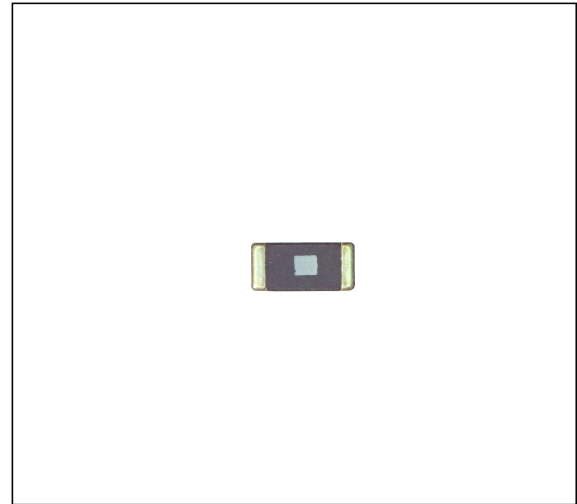


### Description

The HCA5025A2450M25S chip antenna is designed for WiFi/Bluetooth applications. This chip antenna has excellent stability consistently provide high signal reception efficiency.

### Features

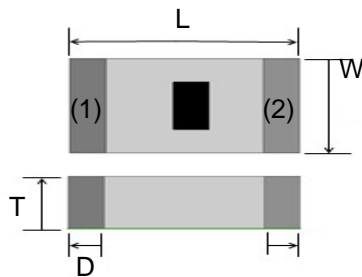
- Dimensions 5.0 x 2.5 x 0.6 (mm)
- Stable and reliable in performances
- Low temperature coefficient of frequency
- Low profile , compact size
- RoHS compliance
- SMT processes compatible



### Applications

- Bluetooth earphone systems
- Hand-held devices when WiFi /Bluetooth functions are needed, e.g., Smart phone.
- IEEE802.11 b/g/n
- ZigBee
- Wireless PCMCIA cards or USB dongle

### Shape and Dimensions / Recommended Pattern



| NO. | Terminal Name |
|-----|---------------|
| [1] | Signal pin    |
| [2] | Single leg    |

Dimensions in mm

| TYPE             | L       | W       | D       | T       |
|------------------|---------|---------|---------|---------|
| HCA5025A2450M25S | 5.0±0.2 | 2.5±0.2 | 0.5±0.2 | 0.6±0.2 |

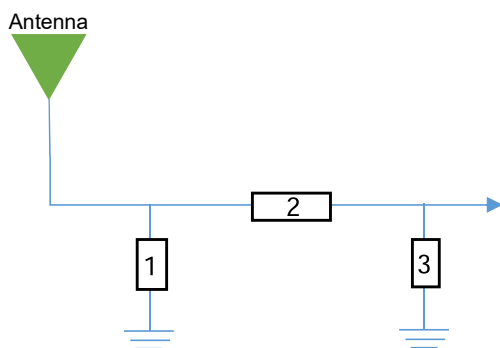
## Electrical Specifications

Electrical Table

| Characteristics    |            | Specifications      | Unit     |
|--------------------|------------|---------------------|----------|
| Outline Dimensions |            | 5.0x2.5x0.6         | mm       |
| Working Frequency  |            | 2400~2500           | MHz      |
| VSWR               |            | 2.5 Max.            |          |
| Impedance          |            | 50                  | $\Omega$ |
| Polarization       |            | Linear Polarization |          |
| Gain               | Peak       | 0~2(typical)        | dBi      |
|                    | Efficiency | 45 (typical)        | %        |

## Matching Circuit

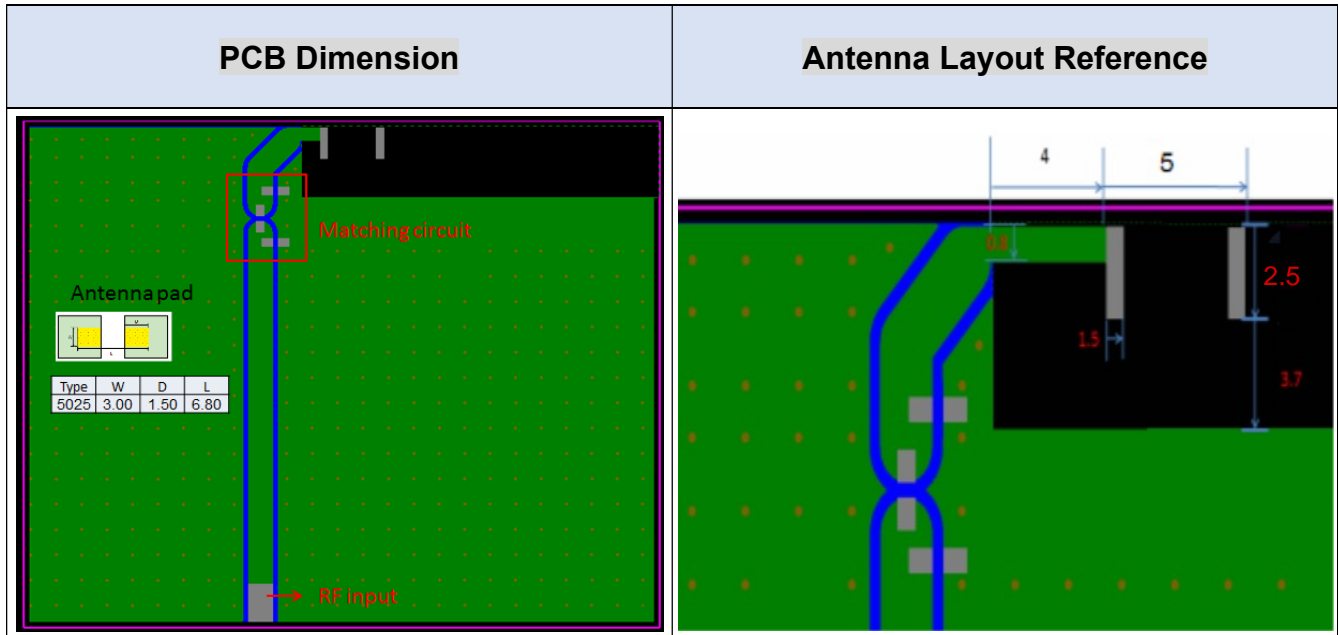
With the following recommended values of matching and tuning components, the center frequencies will be about 2450 MHz at our standard 50x50 mm<sup>2</sup> evaluation board . However, these are reference values, may need to be changed when the circuit boards or part vendors are different.



System Matching Circuit Component

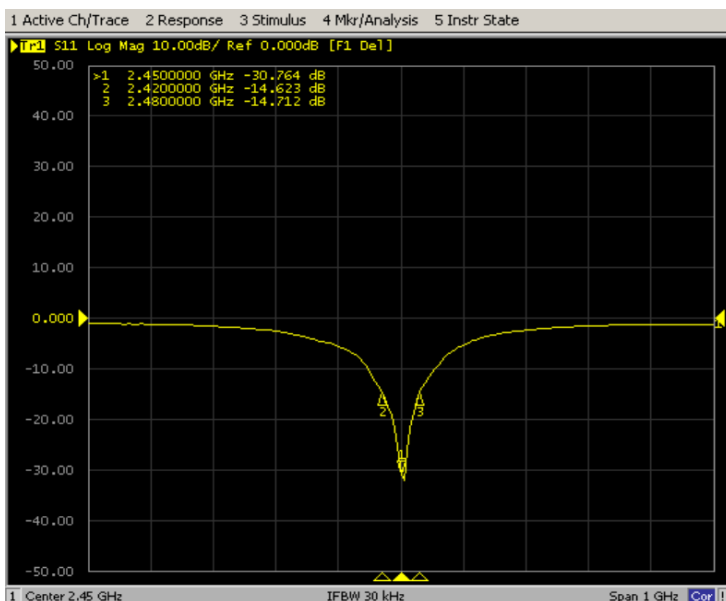
| Location | Description   | Vendor |
|----------|---------------|--------|
| 1        | N/A*          | -      |
| 2        | 1.2pF, (0402) | MURATA |
| 3        | 1.2nH, (0402) | DARFON |
|          |               |        |
|          |               |        |

## Dimensions and Recommended PC Board pattern



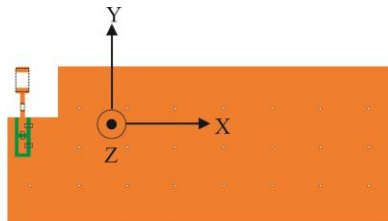
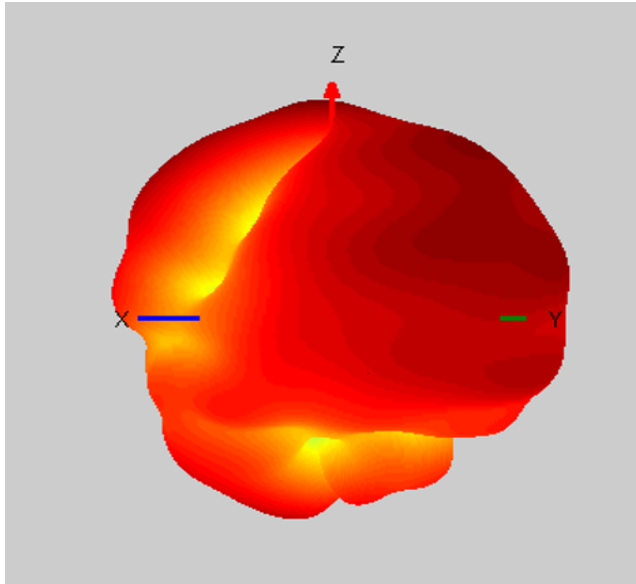
Unit:mm

## Return Loss & Radiation



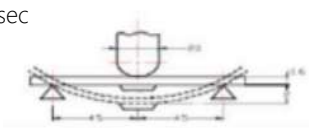
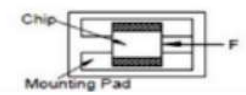
| Frequency (MHz) | Return Loss (dB) |
|-----------------|------------------|
| 2420            | 14.6             |
| 2450            | 30.7             |
| 2500            | 14.7             |

### 3D Radiation



| Frequency (MHz) | Average Gain (dBi) | Peak Gain (dBi) | Efficiency (%) |
|-----------------|--------------------|-----------------|----------------|
| 2400            | -0.74              | 3.7             | 45             |
| 2450            | -0.22              | 3.21            | 48             |
| 2500            | -0.79              | 4.28            | 46             |

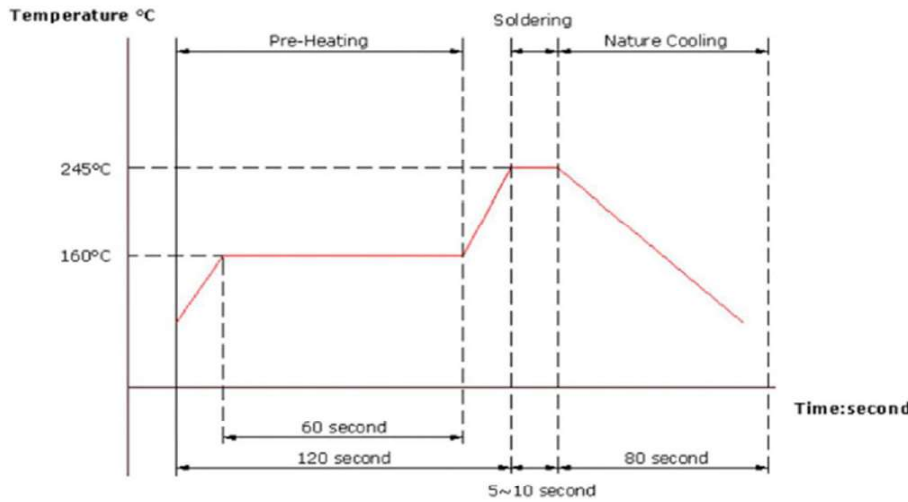
### Reliability Of Ferrite Multilayer Chip Bead

| No    | Item                         | Specification   | Test Method  |
|-------|------------------------------|---|--|
| 1-1-1 | Board Flex                   | The forces applied on the right conditions must not damage the terminal electrode and the ferrite | Test device shall be soldered on the substrate<br>Substrate Dimension: 100x40x1.6mm<br>Deflection: 2.0mm<br>Keeping Time: 60 sec<br>  |
| 1-1-2 | Resistance to Soldering Heat | Meet the electrical Specification after test  | Refer to MIL- STD-202 Method 210<br>Pre-heating:150-200°C ,60-100 sec<br>Above 217°C,60-150 secs<br>Peak Temperature: 260±5°C ,20-40 sec<br>Cycles: 2 times  |
| 1-1-3 | Solder ability               | The electrodes shall be at least 95% covered with new solder coating                              | Refer to J-STD-002<br>Pre-heating:150 °C , 1min<br>Solder Composition: Sn/Ag3.0/Cu0.5(Pb-Free)<br>Solder Temperature: 245±5°C ,(Pb-Free)<br>Immersion Time: 4 ±1sec  |
| 1-1-4 | Terminal Strength Test       | The chip must not damage the terminal electrode and the ferrite                                   | Test device shall be soldered on the substrate<br>Force 2N for 60± 1 seconds for 0603 series<br>Force 5N for 60± 1 seconds for 1005 series<br>Force 10N for 60± 1 seconds for 1608 series<br>Force 1.8Kg for 60± 1 seconds for other series<br> |
| 1-1-5 | Vibration Test               | Meet the electrical Specification after test  | Refer to MIL-STD-202 Method 204<br>Vbration waveform: Sine waveform<br>Vbration frequency: 10Hz~2000Hz<br>Vbration acceleration:5g<br>10Hz-20Hz and back to 10Hz should be in 20 minutes<br>Duration of test:12cycles each of 3 orientations<br>20 minutes for each cycle, 12 hr total<br>Vibration axes:X, Y, & Z                   |
| 1-1-6 | Resistance to Solvent        | There must be no change in appearance or ablation of marking                                      | Refer to MIL-STD-202 Method 215<br>Inductors must withstand 6 mimutes of alcohol or water  |

### Reliability Of Ferrite Multilayer Chip Bead

| No    | Item                                | Specification                               | Test Method  |
|-------|-------------------------------------|---|--|
| 1-2-1 | Temperature Cycle                   | Meet the electrical Specification afer test | Refer to JESD Method JA-104<br>Total cycles: 1000 cycles<br>30 minutes exposure to -40°C<br>30 minutes exposure to 125°C<br>1 min maximum transition between temperatures<br>Measured after exposure in the room condition for 24hrs |
| 1-2-2 | Biased Humidity Resistance          |   | Refer to MIL-STD-202 Method 103<br>Temperature: 85± 2 °C<br>Relative Humidity : 85%/ Time:1000hrs<br><br>Measured after exposure in the room condition for 24hrs   |
| 1-2-3 | High Temperature Exposure (Storage) |   | Refer to MIL-STD-202 Method 108<br>Temperature: 125± 3°C /Relative Humidity: 0%<br>Time:1000hrs<br><br>Measured after exposure in the room condition for 24hrs   |
| 1-2-4 | Low Temperature Exposure (Storage)  | Meet the electrical Specification afer test | Refer to MIL-STD-202 Method 108<br>Temperature: -40± 3°C /Relative Humidity: 0%<br>Applied Current: Rated Current Time:1000hrs<br><br>Measured after exposure in the room condition for 24hrs  |

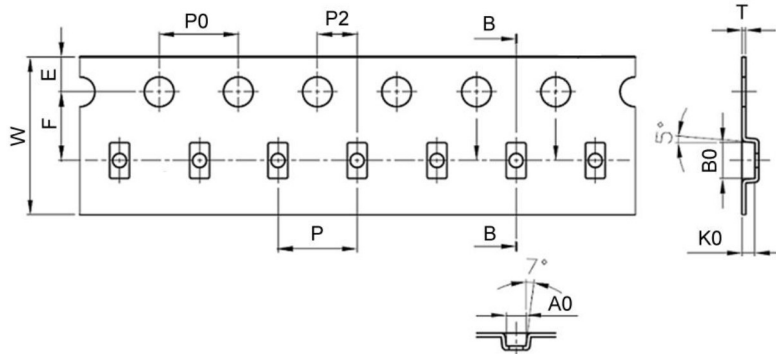
### Slodering Conditions



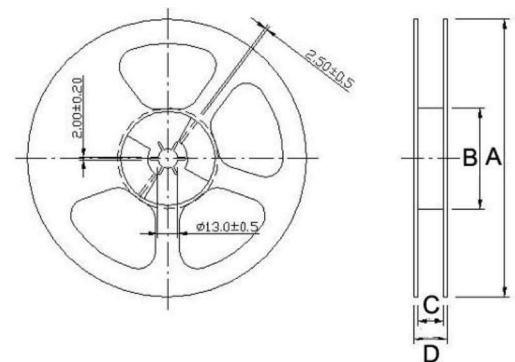
Lead Free Common Mode Fliter IR Reflow Temperature Profile

### Packaging Specifications

Tape Dimensions



Reel Dimensions



Dimensions in mm

| TYPE             | Tape Dimensions |      |      |      |    |   |    |    |     |      | Reel Dimensions |     |      |      | Quantity   |
|------------------|-----------------|------|------|------|----|---|----|----|-----|------|-----------------|-----|------|------|------------|
|                  | A0              | B0   | T    | E    | W  | P | P0 | P2 | F   | K0   | A               | B   | C    | D    | PCS / REEL |
| HCA5025A2450M25S | 2.8             | 5.50 | 0.75 | 1.75 | 12 | 4 | 4  | 2  | 5.5 | 0.73 | 254             | 100 | 13.8 | 20.0 | 4000       |